

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/588,329	LITWIN ET AL.	
Examiner		Art Unit		Page 1 of 2
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,800,027	10-2004	Giobbi et al.	463/24
*	B	US-2004/0248653	12-2004	Barros et al.	463/043
*	C	US-6,633,293 B1	10-2003	Kojima, Hideo	345/473
*	D	US-6,645,076 B1	11-2003	Sugai, Kazutoshi	463/30
*	E	US-6,749,514 B1	06-2004	Moriwaki et al.	463/43
*	F	US-2001/0007827	07-2001	Horikawa, Kentaro	463/22
*	G	US-2004/0224741 A1	11-2004	Jen et al.	463/006
*	H	US-6,612,931 B2	09-2003	Kojima et al.	463/42
*	I	US-6,846,239 B2	01-2005	Washio, Kazuto	463/40
*	J	US-2003/0224856 A1	12-2003	Bukovsky et al.	463/42
*	K	US-6,264,562 B1	07-2001	McSheffrey et al.	463/42
*	L	US-2002/0160833 A1	10-2002	Lloyd et al.	463/29
*	M	US-2003/0114218 A1	06-2003	McClintic, Monica A.	463/25

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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<b>Notice of References Cited</b>		Application/Control No. 10/588,329	Applicant(s)/Patent Under Reexamination LITWIN ET AL.	
		Examiner Steven HD Nguyen	Art Unit 2416	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0224763	11-2004	Lum et al.	463/036
*	B	US-6,918,828 B2	07-2005	Horikawa, Kentaro	463/1
*	C	US-2004/0082387 A1	04-2004	Doi et al.	463/042
*	D	US-2003/0109310 A1	06-2003	Heaton et al.	463/42
*	E	US-2002/0055949	05-2002	Shiomi et al.	707/500
*	F	US-2005/0153768	07-2005	Paulsen, Craig	463/016
*	G	US-6,716,102	04-2004	Whitten et al.	463/43
*	H	US-7,169,050	01-2007	Tyler, Matthew George	463/42
*	I	US-6,951,516	10-2005	Eguchi et al.	463/40
*	J	US-7,214,133	05-2007	Jen et al.	463/42
*	K	US-2007/0105624	05-2007	Tyler, Matthew George	463/029
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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